

# N-Channel Enhancement Mode MOSFET

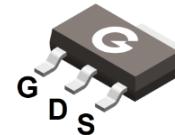
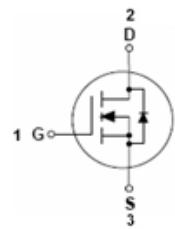
## YK3N20R



### Features

- Advanced Trench technology
- Low gate drive voltage (Logic level capable)
- Low input capacitance
- Low on-resistance
- Fast switching speed
- RoHS compliant with Halogen-free

HF



SOT-223

### Mechanical Data

- Case: SOT-223
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
YK3N20R	SOT-223	4000 pcs / Tape & Reel	3N20

### Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	200	V
Gate-to-Source Voltage	$V_{GSS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	3	A
Pulsed Drain Current ( $t_p = 10\mu\text{s}$ , $T_A = 25^\circ\text{C}$ )	$I_{DM}$	12	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	1	mJ

### Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ( $T_A = 25^\circ\text{C}$ ) <sup>1</sup>	$P_D$	3.1	W
Thermal Resistance Junction-to-Air <sup>1</sup>	$R_{\theta JA}$	40.3	°C/W
Operating Junction Temperature Range	$T_J$	-55 ~ +150	°C
Storage Temperature Range	$T_{STG}$	-55 ~ +150	°C

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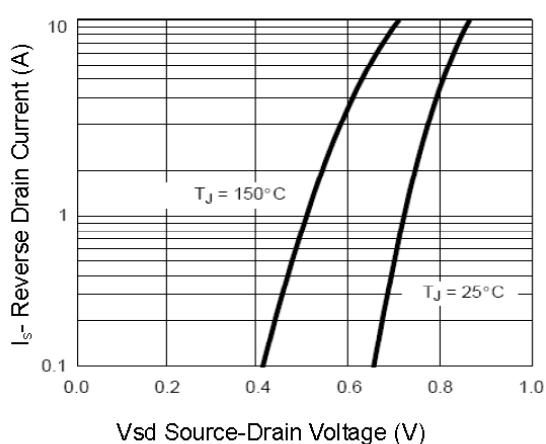
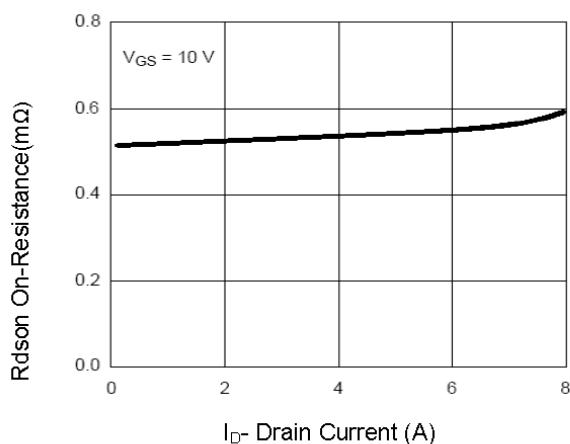
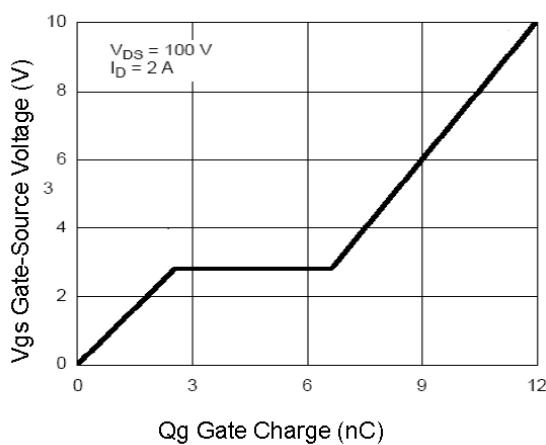
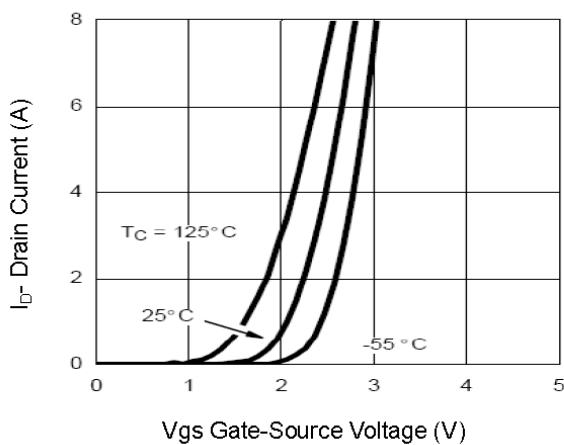
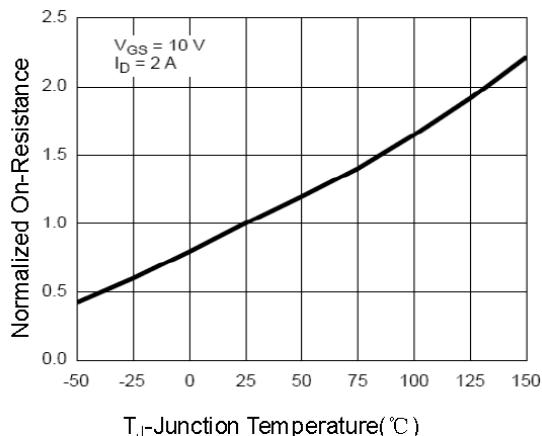
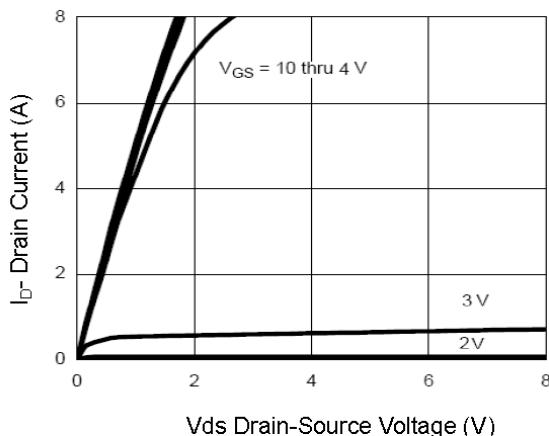
### Electrical Characteristics (@ $T_A = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
$V_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	200	-	-	V
$I_{DS(on)}$	Zero Gate Voltage Drain Current	$V_{DS} = 200V, V_{GS} = 0V$	-	-	1	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$R_{DS(on)}$	Drain-Source On-resistance <sup>*2</sup>	$V_{GS} = 10V, I_D = 3A$	-	0.65	0.75	$\Omega$
		$V_{GS} = 5V, I_D = 3A$	-	0.67	0.78	$\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	1.6	2.5	V
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1.0MHz$	-	580	-	pF
$C_{oss}$	Output Capacitance		-	90	-	
$C_{rss}$	Reverse Transfer Capacitance		-	3	-	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-on Delay Time <sup>*4</sup>	$V_{DD} = 100V$ $V_{GS} = 10V$ $R_G = 2.5\Omega$ $R_L = 15\Omega$	-	10	-	ns
$t_r$	Turn-on Rise Time <sup>*4</sup>		-	12	-	
$t_{d(off)}$	Turn-Off Delay Time <sup>*4</sup>		-	15	-	
$t_f$	Turn-Off Fall Time <sup>*4</sup>		-	15	-	
$Q_G$	Total Gate-Charge	$V_{DD} = 100V$ $V_{GS} = 10V$ $I_D = 2A$	-	12	-	nC
$Q_{GS}$	Gate to Source Charge		-	2.5	-	
$Q_{GD}$	Gate to Drain (Miller) Charge		-	3.8	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage <sup>*2</sup>	$I_{SD} = 2A, V_{GS} = 0V$	-	0.86	0.95	V
$t_{rr}$	Reverse recovery time	$I_S = 2A, V_{GS} = 0V,$ $di/dt = 100A/\mu s$	-	177	-	ns
$Q_{rr}$	Reverse recovery charge		-	1.4	-	$\mu C$

Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
3. The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD} = 50V, V_{GS} = 10V, L = 0.5mH$
4. Guaranteed by design, not subject to production

### Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)



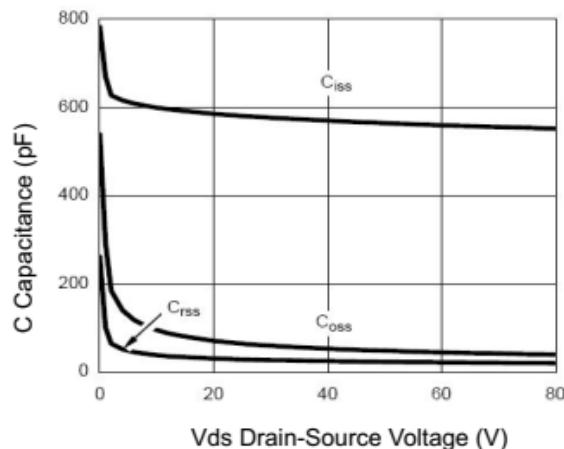


Figure 7 Capacitance vs  $V_{ds}$

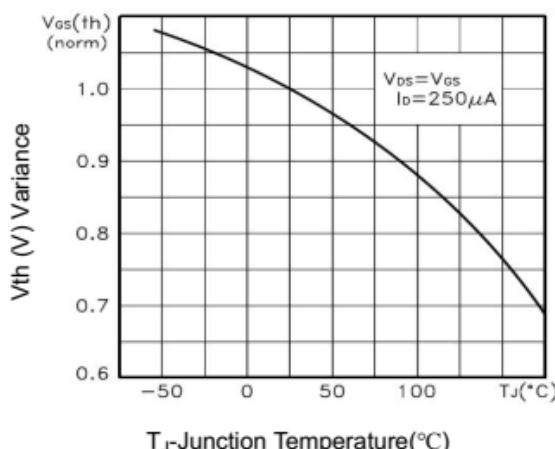


Figure 9  $V_{GS(th)}$  vs Junction Temperature

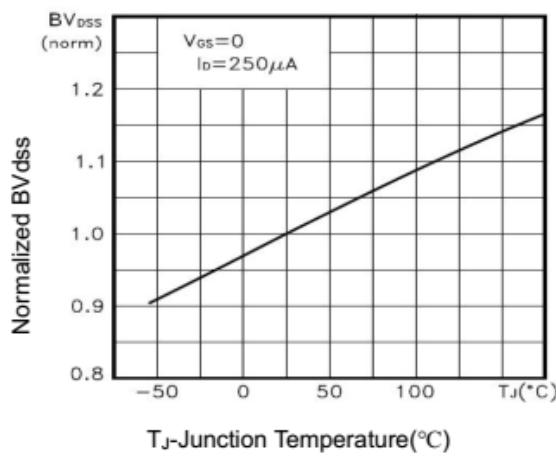
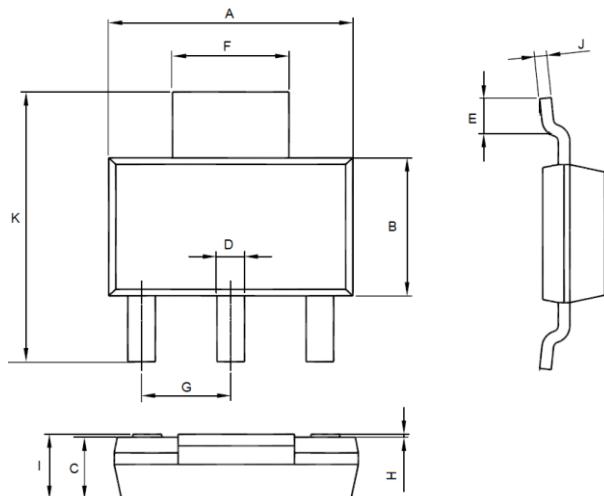


Figure 8  $BV_{dss}$  vs Junction Temperature

**YK3N20R****Package Outline Dimensions** (Unit: mm)

SOT-223		
Dimension	Min.	Max.
A	6.10	6.50
B	3.30	3.70
C	1.50	1.70
D	0.66	0.82
E	0.90	1.15
F	2.90	3.10
G	2.20	2.40
H	0.02	0.10
I	1.52	1.80
J	0.20	0.40
K	6.70	7.30

**Mounting Pad Layout** (Unit: mm)